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Back Matter

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Contents

Call for Papers ................................................................................................................................. 2
Guide for Submission of Manuscripts ............................................................................................. 2
Forensic Analysis of a Crash-Damaged Cheerson CX-20 Auto Pathfinder Drone ............ 5
Ian Noel McAteer, Peter Hannay, Muhammad Imran Malik and Zubair Baig

Russia Today, Cyberterrorists Tomorrow: U.S. Failure to Prepare Democracy for
Cyberspace ........................................................................................................................................ 23
Jonathan F. Lancelot

Chip-Off Success Rate Analysis Comparing Temperature and Chip Type .................. 33
Choli Ence, Joan Runn Through and Gary Cantrell

Publication Information ................................................................................................................... 61